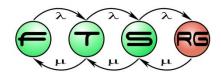
#### Software and Systems Verification (VIMIMA01)

# Dependability Analysis

Kristóf Marussy, István Majzik

# **Budapest University of Technology and Economics Fault Tolerant Systems Research Group**





#### Main topics of the course

- Overview (1.5)
  - Introduction, V&V techniques
- Static techniques (1.5)
  - Specification, Verifying source code
- Dynamic techniques: Testing (7)
  - Testing overview, Test design techniques
  - Test generation, Automation
- System-level verification (3)
  - Verifying architecture, Dependability analysis
  - Runtime verification





#### **Table of Contents**

- Attributes of dependability
  - Reliability, availability
  - Safety, integrity, maintainability
- Combinatorial models for dependability analysis
  - Reliability block diagrams
- Stochastic models for dependability analysis
  - Markov models (CTMC)





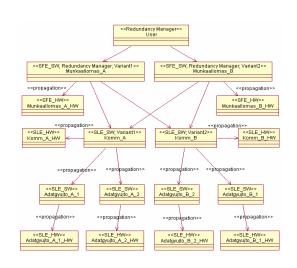
#### Learning outcomes

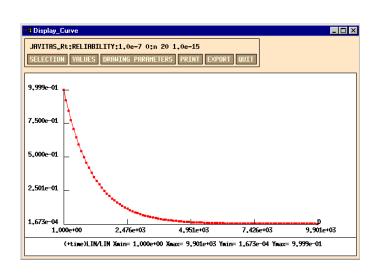
- Explain the attributes of dependability and the objectives of dependability analysis (K2)
- Perform dependability analysis with reliability block diagrams (K3)
- Perform dependability analysis of simple redundancy structures with Markov chains (K3)
- Identify how reward analysis can be used for dependability analysis (K1)





# Attributes of dependability









# Characterizing the system services

- Typical extra-functional characteristics
  - Reliability, availability, integrity, ...
  - Depend on the faults occurring during the use of the services
- Composite characteristic: Dependability
  - Definition: Ability to provide service in which reliance can justifiably be placed
    - Justifiably: based on analysis, evaluation, measurements
    - Reliance: the service satisfies the needs
- Role of dependability
  - Service Level Agreements (IT service providers)
  - Tolerable Hazard Rate (safety-critical systems)





# Attributes of dependability

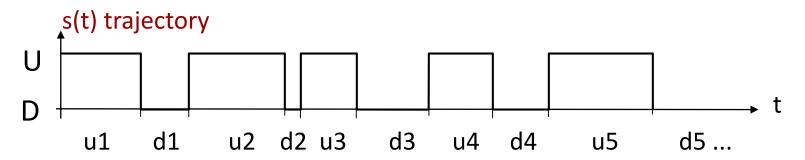
Attribute	Definition
Availability	Probability of correct service (considering repairs and maintenance)  "Availability of the web service shall be 95%"
Reliability	Probability of continuous correct service (until the first failure)  "After departure, the flight control system shall function correctly for 12 hours"
Cofoty	·
Safety	Freedom from unacceptable risk of harm
Integrity	Avoidance of erroneous changes or alterations
Maintainability	Possibility of repairs and improvements





#### Dependability metrics: Mean values

- Basis: Partitioning the states of the system
  - Correct (U, up) and incorrect (D, down) state partitions



- Mean values:
  - O Mean Time to First Failure: MTFF = E{u1}
  - Mean Up Time: MUT = MTTF = E{ui}(Mean Time To Failure)
  - Mean Down Time: MDT = MTTR = E{di}(Mean Time To Repair)
  - Mean Time Between Failures: MTBF = MUT + MDT



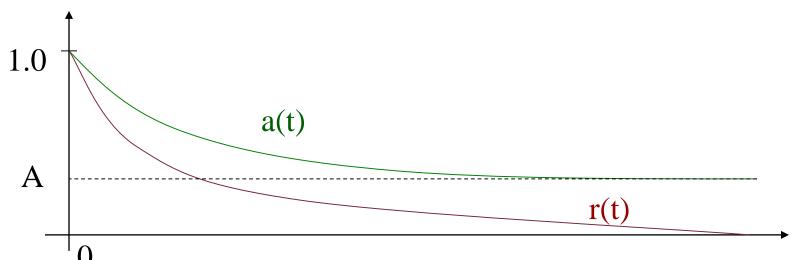


#### Dependability metrics: Probability functions

- Availability:  $a(t) = P\{s(t) \in U\}$
- Asymptotic availability:  $A = \lim_{t \to \infty} a(t)$

$$A = \frac{MTTF}{MTTF + MTTR}$$

• Reliability:  $r(t) = P\{s(t') \in U, \forall t' < t\}$ 







#### Availability related requirements

Availability	Failure period per year			
99%	~ 3,5 days			
99,9%	~ 9 hours			
99,99% ("4 nines")	~ 1 hour			
99,999% ("5 nines")	~ 5 minutes			
99,9999% ("6 nines")	~ 32 sec			
99,99999%	~ 3 sec			

Availability of a system built up from components, where the availability of single a component is 95%, all components are needed to perform the system function:

system built from 2 components: 90%

system built from 5 components : 77%

system built from 10 components: 60%





#### Attributes of components

• Fault rate:  $\lambda(t)$ 

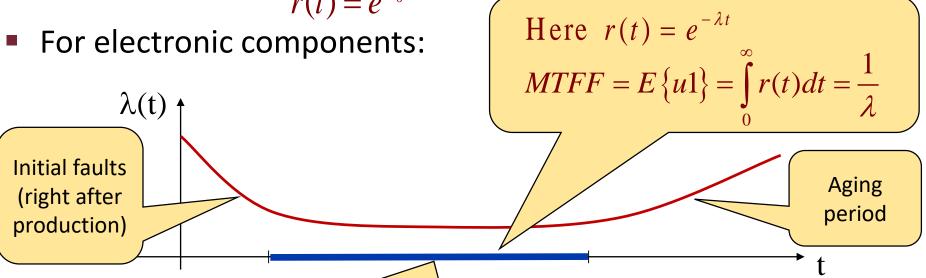
The probability that the component will fail in the interval  $\Delta t$  at time point t given that it has been correct until t is given by  $\lambda(t)\Delta t$ :

$$\lambda(t)\Delta t = P\{s(t+\Delta t) \in D \mid s(t) \in U\} \text{ while } \Delta t \to 0$$

Reliability of a component on the basis of this definition:

$$r(t) = e^{-\int_{0}^{t} \lambda(t)dt}$$

For electronic components:



#### Analysis techniques

- Qualitative analysis techniques:
  - Fault effects analysis: What are the component level failures (failure modes), that cause system level failure?
    - Identification of single points of failure
  - Techniques: Systematic causes and effects analysis
    - Fault tree analysis (FTA), Event tree analysis (ETA), Cause-consequence analysis (CCA), Failure modes and effects analysis (FMEA)
- Quantitative analysis techniques:
  - Dependability analysis: How can the system level dependability be calculated on the basis of component level fault properties?
    - System level reliability, availability, ...
  - Techniques: Construction and solution of dependability models
    - Reliability block diagrams (RBD)
    - Markov-chains (MC)
    - Stochastic Petri nets (SPN)





# Goals of the dependability analysis

- On the basis of component characteristics
  - fault rate (in continuous operation),
     measured by FIT: 1 FIT = 10<sup>-9</sup> faults/hour
  - fault probability (in on-demand operation)
  - reliability function
  - calculation of system level characteristics
    - reliability function
    - availability function
    - asymptotic availability
    - MTFF
    - safety

Calculations are based on the system architecture and the failure modes





# Using the results of the analysis

- Design: Comparison of alternative architectures
  - Having the same components, which architecture guarantees better dependability attributes?
- Design, maintenance: Sensitivity analysis
  - What are the effects of selecting another component?
  - Which components have to be changed in case of inappropriate attributes?
  - Which component characteristics have to be investigated in more detail? → Fault injection and measurements
- Handover: Justification of dependability attributes
  - Approval and startup of services
  - Certification (for safety critical systems)





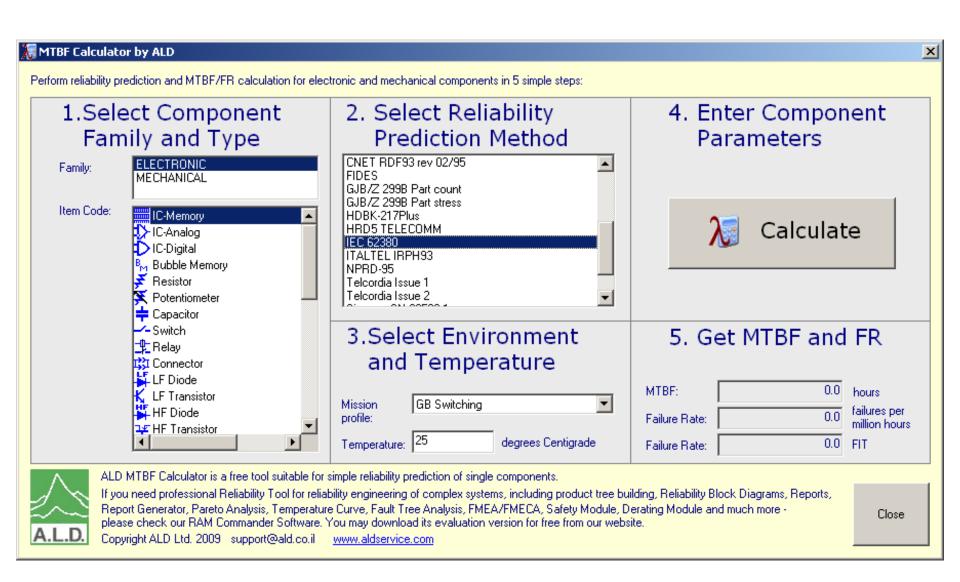
# How to estimate component fault rate?

- Component level fault rates are available in handbooks
  - MIL-HDBK-217: The Military Handbook Reliability Prediction of Electronic Equipment (for military applications. pessimistic)
  - Telcordia SR-332: Reliability Prediction Procedure for Electronic Equipment (for telco applications)
  - IEC TR 62380: Reliability Data Handbook Universal Model for Reliability Prediction of Electronic Components, PCBs, and Equipment (less pessimistic, supporting new component types)
- Dependencies of component level reliability data:
  - Temperature, weather conditions, shocking (e.g., in vehicles), height, ...
  - Operational profiles
    - Ground; stationary; weather protected (e.g., in rooms)
    - Ground; non stationary; moderate (e.g., in vehicles)





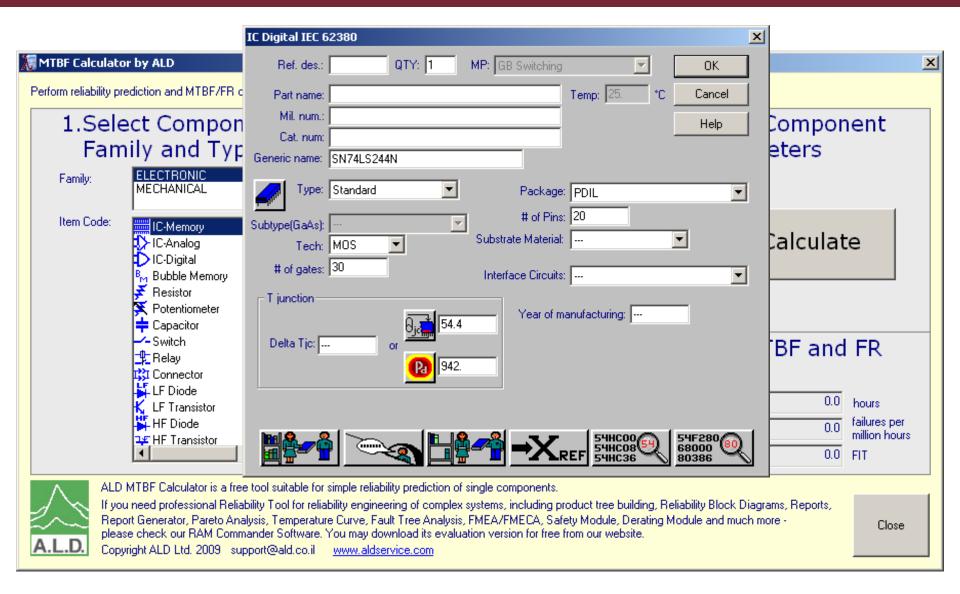
#### Tool example: The ALD MTBF Calculator







#### Tool example: The ALD MTBF Calculator

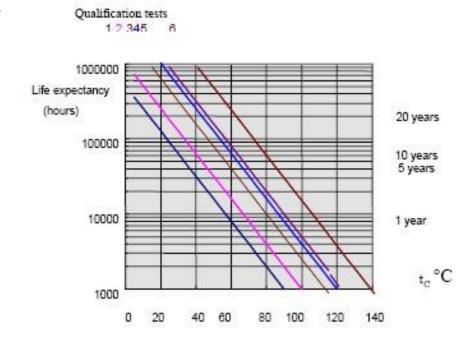






# Estimation of life expectancy

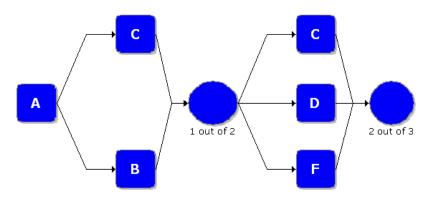
- What is the lifetime of electronic components?
  - When does the fault rate start increasing?
  - At this time scheduled maintenance (replacement) is required
- IEC 62380: "Life expectancy"
- Especially limited: In case of electrolyte capacitors
  - Depends on temperature
  - Depends on qualification
  - Example: at 25°C,~ 100 000 hours (~ 11 years)







# Combinatorial models for dependability analysis







#### Boolean models for calculating dependability

- Two states of components: Fault-free or faulty
- There are no dependences among the components
  - Neither from the point of view of fault occurrences
  - Nor from the point of view of repairs
- "Interconnection" of components from the point of view of dependability: What kind of redundancy is used?
  - Serial connection: The components are not redundant
    - If all components are necessary for the system operation
  - Parallel connection: The components are redundant
    - If the components may replace each other





# Reliability block diagram

Blocks: Components (with failure modes)

Connection: Serial or parallel connection

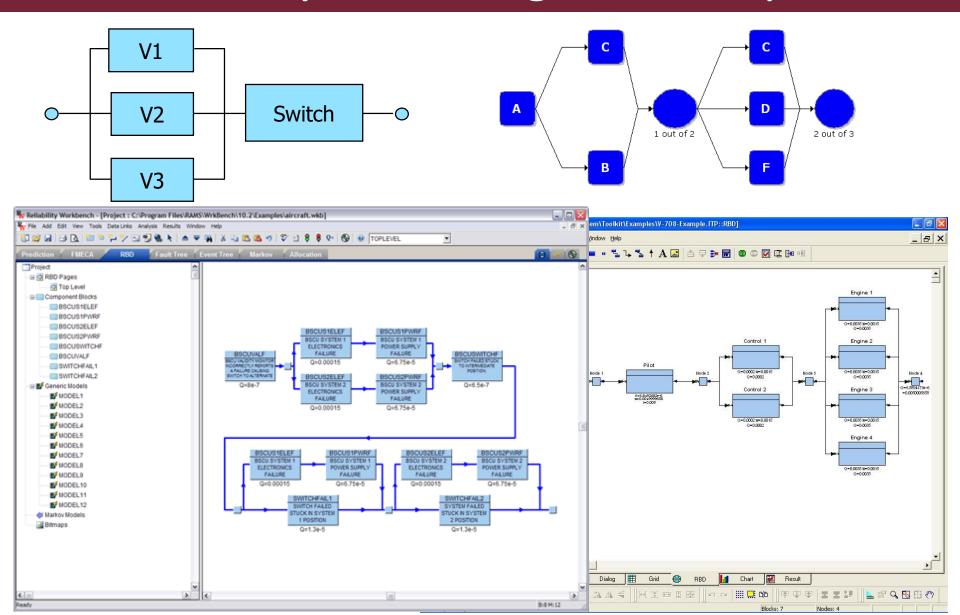
Paths: System configurations

 The system is operational (correct) if there is a path from the start point to the end point of the diagram through fault-free components

Serial: Parallel:  $C_1$   $C_1$   $C_2$   $C_3$ 



#### Reliability block diagram examples

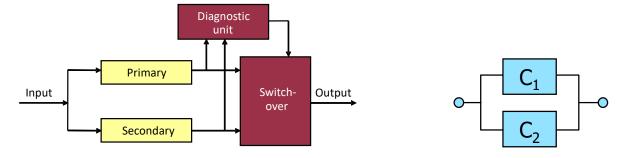




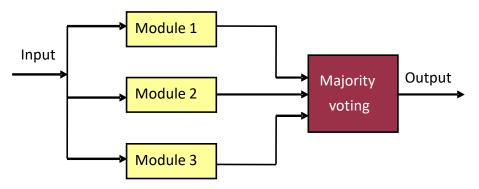


#### Overview: Typical system configurations

- Serial system model: No redundancy
- Parallel system model: Redundancy (replication)



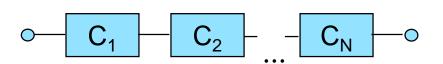
- Complex canonical system: Redundant subsystems
- M out of N components: Majority voting (TMR)

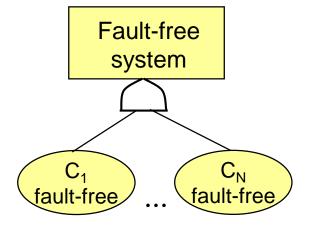






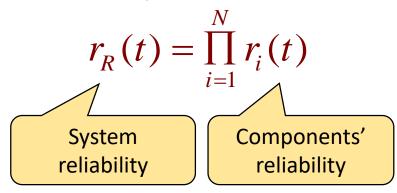
# Serial system model





 $P(A \land B) = P(A) \cdot P(B)$ If independent

Reliability for N components:



$$\lambda_R = \sum_{i=1}^N \lambda_i$$

MTFF:

$$MTFF = \frac{1}{\sum_{i=1}^{N} \lambda_i}$$





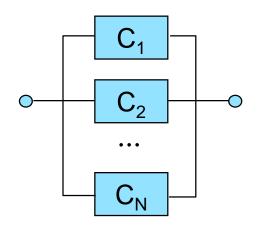
#### Example: Reliability of a module (serial system)

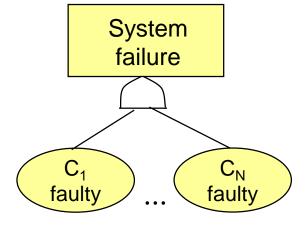
Component name	Туре	Additional	data	IEC 62380 referei	nce	Fault rate	Quantity
Panduit D461612	Connector	Rectangular		Default value		0,003625	1
Panduit D461612	Connector	Rectangular		Default value		0,007200	1
74AHCT14	IC-Digital	Standard		Substituted with - SN74AHCT14D		0,014200	3
74HC/HCT540	IC-Digital	Standard		Substituted with - CD74HC540E		0,019000	2
74HC/HCT541	IC-Digital	Standard		Substituted with - SN74AHCT541DW		0,014000	3
PALCE16V8	IC-Digital	PAL		Exact matching		0,036000	1
HMA124	Optoelectronic	Optocoupler		Default value		0,011600	16
MB6S	IC-Digital	Standard		Default value		0,012700	16
Resistor	Resistor	General purpose		Default value		0,000232	32
Resistor	Resistor	Fixed, high dissipation film		Default value		0,001047	32
Capacitor	Capacitor	Tantalum - solid electrolyte		Default value		0,000725	17
Capacitor	Capacitor	Ceramic class II.		Default value		0,000223	41
SMD led	Optoelectronic	Solid State				0,002000	16
U22-DI016-C3	PWB		Sum	of component		0,003403	1
SOD80 BZV55C	LF Diode	Zener	fault r	rate * quantity		0,011500	64
Module fault rate:					1,	392021 faults pe	r million hours





# Parallel system model





 $P(A \land B) = P(A) \cdot P(B)$  if independent

Reliability:

$$1 - r_R(t) = \prod_{i=1}^{N} (1 - r_i(t))$$

Identical N components:

$$r_R(t) = 1 - (1 - r_C(t))^N$$

MTFF:

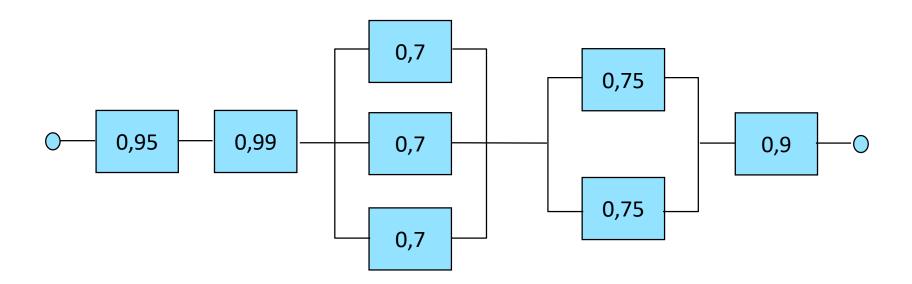
$$MTFF = \frac{1}{\lambda} \sum_{i=1}^{N} \frac{1}{i}$$





#### Complex canonical system

- Calculation on the basis of parts with basic connections
  - Example: Calculation of asymptotic availability



$$K_R = 0.95 \cdot 0.99 \cdot \left[1 - (1 - 0.7)^3\right] \cdot \left[1 - (1 - 0.75)^2\right] \cdot 0.9$$





# M faulty out of N components

N replicated components; If M or more components are faulty: the system is faulty

$$r_R = \sum_{i=0}^{M-1} P\{\text{"there are i faulty components"}\}$$

$$r_{R} = \sum_{i=0}^{M-1} {N \choose i} (1-r)^{i} \cdot r^{N-i}$$

Application: Majority voting (TMR): N=3, M=2

$$r_{R} = \sum_{i=0}^{1} {3 \choose i} (1-r)^{i} \cdot r^{3-i} = {3 \choose 0} (1-r)^{0} \cdot r^{3} + {3 \choose 1} (1-r)^{1} \cdot r^{2} = 3r^{2} - 2r^{3}$$

$$MTFF = \int_{0}^{\infty} r_R(t)dt = \int_{0}^{\infty} (3r^2 - 2r^3)dt = \frac{5}{6} \cdot \frac{1}{\lambda}$$
 Less than in case of a single component!





# Cold redundant system

A new component is switched on to replace a faulty component:

$$MTFF = \sum_{i=1}^{N} MTFF_i$$

In case of identical replicated components, the system reliability function:

$$r_{R}(t) = \sum_{i=0}^{N-1} \frac{\left(\lambda t\right)^{i}}{i!} e^{-\lambda t}$$





#### **EXERCISE**

#### Reliability block diagram

A SCADA system consists of the following components:

- 4 data collector units, 3 control units, 2 supervisory servers, 1 logging server and the corresponding network
- The 2 supervisory servers are in a hot redundancy structure.
- 2 data collector units and 2 control units are hot redundant units
- The reliability data of the system components are given as follows (measured in hours, with independent repairs in case of faults):

	Data coll. unit	Control unit	Superv. server	Logging server	Network
MTTF	9000	12000	4500	2000	30000
MTTR	2	3	5	1	2

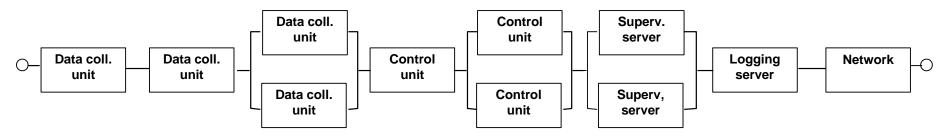
- Evaluate the system level availability using a reliability block diagram.
- Compute the asymptotic availability of the system using the above given parameters of the system components.
- In average, how many hours is the system out of service in a year?





#### **EXERCISE** Solution

#### Reliability block diagram:



Component level asymptotic availability: K = MTTF / (MTTF+MTTR)

	Data coll. unit (D)	Control unit (C)	Superv. server (S)	Logging server (L)	Network (N)
MTTF	9000	12000	4500	2000	30000
MTTR	2	3	5	1	2
K	KD=0.99977	KC=0.99975	KS=0.99889	KL=0.9995	KN=0.99993

System level asymptotic availability:

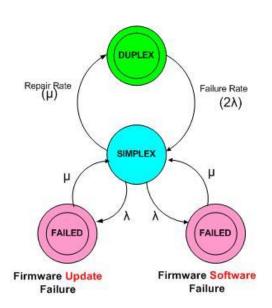
$$KD*KD*(1-(1-KD)^2) * KC*(1-(1-KC)^2) * (1-(1-KS)^2) * KL * KN = 0.9987362$$

Approx. 11 hours out of service per year





# Markov models for dependability analysis



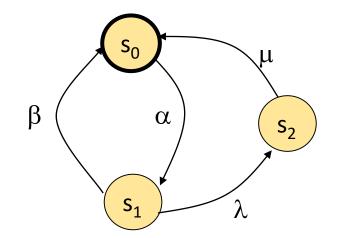




#### Model: Continuous Time Markov Chain

- Definition: CTMC = (S, R)
  - S set of discrete states:

 $\circ \underline{\mathbb{R}}: S \times S \longrightarrow \mathbb{R}_{\geq 0}$  state transition rates



- Notation:
  - Rate of leaving a state:  $E(s) = \sum_{s' \in S, s \neq s'} R_{s,s'}$
  - $\bigcirc$  **Q** = **R**-diag(**E**) infinitesimal generator matrix
  - $\circ \sigma = s_0, t_0, s_1, t_1, \dots$  path  $(s_i \text{ is left at } t_i)$
  - o σ@t the state at time t
  - Path(s) set of paths from s





#### Solution of a CTMC

- Transient state probabilities:
  - $\pi(s_0, s, t) = P\{\sigma \in Path(s_0) \mid \sigma@t=s\}$  probability that starting from  $s_0$  the system is in state s at time t
  - $\circ \underline{\pi}(s_0, t)$  starting from  $s_0$ , the probabilities of the states at t
  - o CTMC transient solution:

$$\frac{d\underline{\pi}(s_0,t)}{dt} = \underline{\pi}(s_0,t)\underline{Q}$$

$$P\{\text{being in } s \text{ for } t\} = e^{-E(s)t}$$

$$E\{\text{time spent in } s\} = \frac{1}{E(s)}$$

- Steady state probabilities:
  - $\pi(s_0, s) = \lim_{t \to \infty} \pi(s_0, s, t)$  state probabilities, starting from  $s_0$
  - $\circ \underline{\pi}(s_0)$  state probabilities (vector)
  - CTMC steady state solution:

$$\underline{\pi}(s_0) \underline{\underline{Q}} = 0$$
 where  $\sum_{s} \pi(s_0, s) = 1$ 

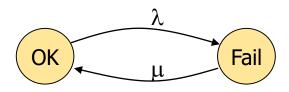




# CTMC dependability model

#### CTMC states

- System level states: Combination of component states (fault-free, or faulty according to a failure mode)
- CTMC transitions
  - $\circ$  Component level fault occurrence: Rate of the transition is the component fault rate  $\lambda$
  - $\circ$  Component level repair: Rate of the transition is the component repair rate  $\mu$ , which is the reciprocal of the repair time



System level repair:
 Rate of the transition is the system repair rate
 (which is the reciprocal of the system repair time)





#### Example: CTMC dependability model

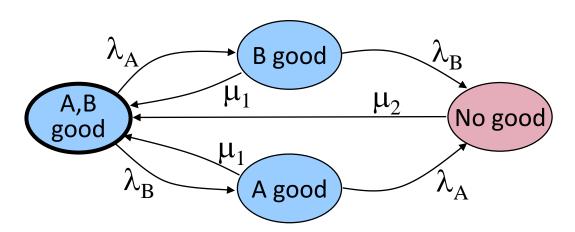
- System consisting of two servers, A and B:
  - The servers may independently fail
  - The servers can be repaired independently or together
- System states: Combination of the server states (good/faulty)
- Transition rates:

 $\circ$  Fault of server A:  $\lambda_{\Delta}$  failure rate

 $\circ$  Fault of server B:  $\lambda_{R}$  failure rate

 $\circ$  Repair of a server:  $\mu_1$  repair rate

 $\circ$  Repair of both servers:  $\mu_2$  repair rate







#### Computation of system level attributes

- Identifying state partitions
  - System level "up" state partition U and "down" partition D
- Solution of the CTMC model:
  - $\circ$  Transient solution:  $\pi(s_0, s, t)$  time functions
  - $\circ$  Steady state solution:  $\pi(s_0, s)$  probabilities
- Availability:  $a(t) = \sum_{s \in U} \pi(s_0, s_i, t)$
- Asymptotic availability:  $A = \sum_{s_i \in U} \pi(s_0, s_i)$
- Reliability:  $r(t) = \sum_{s_i \in U} \pi(s_0, s_i, t)$

Here: Before the solution the model shall be modified: transitions from partition D to U shall be deleted





# Example: CTMC dependability model

- System consisting of two servers, A and B:
  - The servers may independently fail
  - The servers can be repaired independently of together
- State partitions:

$$O = \{s_{AB}, s_{A}, s_{B}\}, s_{O} = s_{AB}$$

$$O$$
 D =  $\{s_N\}$ 

Availability:

$$a(t) = \pi(s_0, s_{AB}, t) + \pi(s_0, s_{A}, t) + \pi(s_0, s_{B}, t)$$

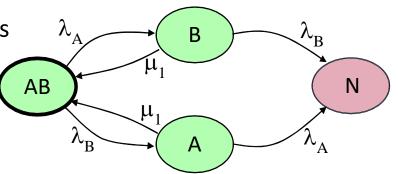
Asymptotic availability:

$$K = A = \pi(s_0, s_{AB}) + \pi(s_0, s_{A}) + \pi(s_0, s_{B})$$

AB

- Reliability:
  - Modifying the model: Deleting transitions from D = {s<sub>N</sub>} partition to U
  - Solution of the modified model:

$$r(t) = \pi(s_0, s_{AB}, t) + \pi(s_0, s_A, t) + \pi(s_0, s_B, t)$$





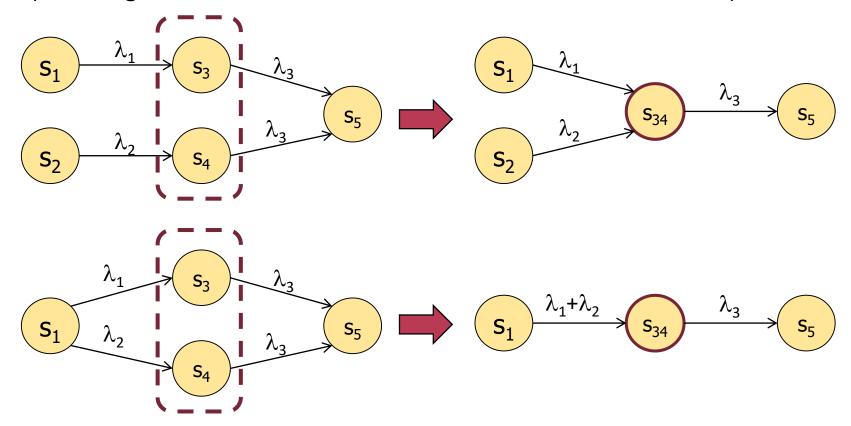


N

#### Reducing CTMC models

#### Merging states

- Condition: Have transitions to the same states with the same rates (outgoing transitions and rates do not distinguish these states)
- After merging, the outgoing rate and the incoming rates remain the same (incoming transitions from the same state: rates are summarized)

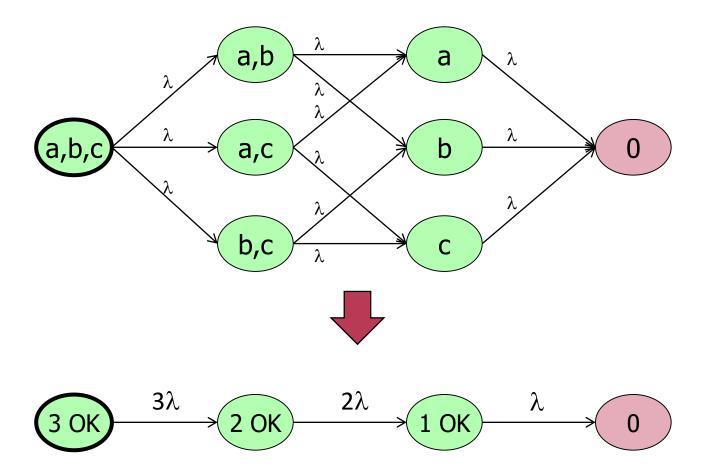






#### Example: Merging states

- Model: 3 redundant (replicated) components
- The components (a, b, c) have the same fault rate  $\lambda$

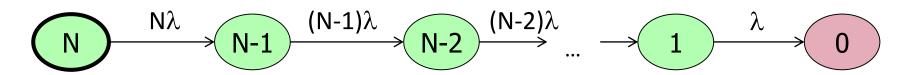




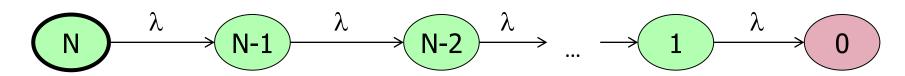


# CTMC dependability models (1)

Hot redundancy, N components:



- Computing MTTF in case of hot redundancy
  - $\circ$  Time spent in state where k components are good:  $\frac{1}{k\lambda}$
- Cold redundancy, N components:

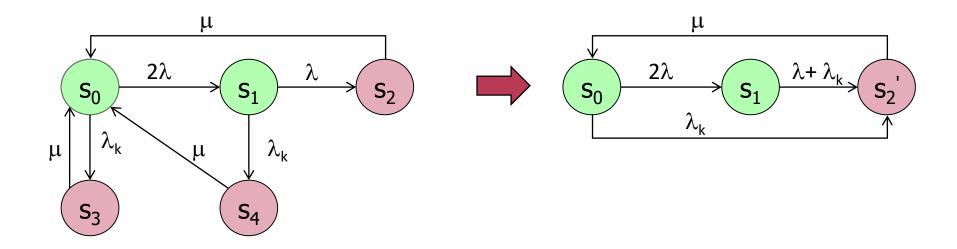






# CTMC dependability models (2)

- Active redundancy scheme
  - $\circ$  2 components, each with  $\lambda$  failure rate
  - $\circ$  Switch between components, with  $\lambda_k$  failure rate
  - $\circ$  In case of a fault: complete repair, with  $\mu$  repair rate



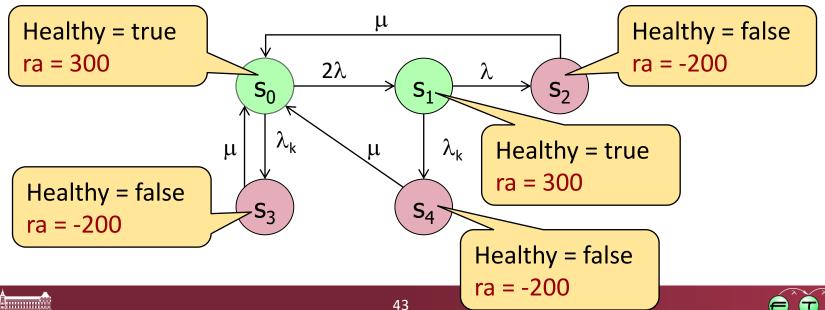




#### Rewards

- Reward: "Profit" or "cost" functions that can be assigned to markings or firings
- Rate reward
  - Assigned to states, reward/time value is given by a function
  - Example: If the server is healthy then the profit is 300 Ft/hour, otherwise the penalty is 200 Ft/hour:

if (Healthy) then ra=300 otherwise ra=-200







#### Rewards

- Reward: "Profit" or "cost" functions that can be assigned to markings or firings
- Rate reward
  - Assigned to states, reward/time value is given by a function
  - Example: If the server is healthy then the profit is 300 Ft/hour, otherwise the penalty is 200 Ft/hour:

```
if (Healthy) then ra=300 otherwise ra=-200
```

- Possible analysis questions
  - Accumulated reward (e.g., profit or penalty) for a time interval *Example:* Cost of operating the system throughout the first month
  - Transient instantaneous reward rate (of change) at a given time point Example: Operating cost for one hour at the end of the first month
  - Steady-state instantaneous reward rate: long-running average cost Example: Operating cost for one hour after a long time





# Tools for dependability analysis

#### For both combinational dependability model

o Fault tree,

Reliability block diagram,

Event tree,

FME(C)A, ...

#### and Markov chains:

- Item Toolkit (<u>www.itemuk.com</u>)
- RAM Commander (<u>www.aldservice.com</u>)
- Functional Safety Suite

#### Open source tools:

- PRISM Model Checker (<u>www.prismmodelchecker.org</u>)
- Storm Model Checker (<u>www.stormchecker.org</u>)





#### Summary

- Attributes of dependability
  - Reliability, availability:
     Probability functions (in time)
- Combinational modeling: Reliability block diagram
  - Serial, parallel, majority voting structures
- State based models: Markov chains
  - Computation: Probability of state partitions
- Profits and costs in models: Rewards
  - Computation: Transient, accumulated and steady-state



